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Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

General Description

The MAX5158/MAX5159 low-power, serial, voltage-output, dual, 10-bit digital-to-analog converters (DACs) consume only 500 μ A from a single +5V (MAX5158) or +3V (MAX5159) supply. These devices feature Rail-to-Rail® output swing and are available in a space-saving 16-pin QSOP package. To maximize dynamic range, the DAC output amplifiers are configured with an internal gain of +2V/V.

The 3-wire serial interface is SPI™/QSPI™ and Microwire™ compatible. Each DAC has a double-buffered input organized as an input register followed by a DAC register, which allows the input and DAC registers to be updated independently or simultaneously with a 16-bit serial word. Additional features include a 2 μ A programmable shutdown, hardware-shutdown lockout, a separate reference-voltage input for each DAC that accepts AC and DC signals, and an active-low clear input (CL) that resets all registers and DACs to zero. The MAX5158/MAX5159 provide a programmable logic pin for added functionality and a serial-data output pin for daisy chaining.

Applications

Digital Offset and Gain Adjustment

μ P-Controlled Systems

Motion Control

Remote Industrial Controls

Features

- ◆ 10-Bit Dual DAC with Internal Gain of +2V/V
- ◆ Rail-to-Rail Output Swing
- ◆ 8 μ s Settling Time
- ◆ Single-Supply Operation: +5V (MAX5158)
+3V (MAX5159)
- ◆ Low Quiescent Current: 500 μ A (normal operation)
2 μ A (shutdown mode)
- ◆ SPI/QSPI and Microwire Compatible
- ◆ Available in Space-Saving 16-Pin QSOP Package
- ◆ Power-On Reset Clears Registers and DACs to Zero
- ◆ Adjustable Output Offset

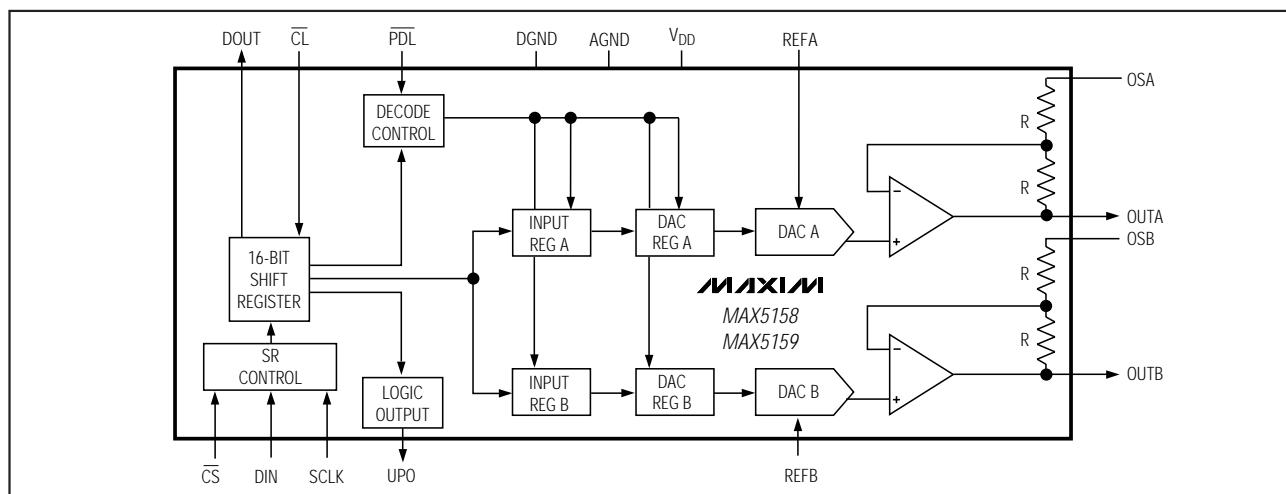
Ordering Information

| PART | TEMP. RANGE | PIN-PACKAGE |
|------------|-----------------|----------------|
| MAX5158CPE | 0°C to +70°C | 16 Plastic DIP |
| MAX5158CEE | 0°C to +70°C | 16 QSOP |
| MAX5158EPE | -40°C to +85°C | 16 Plastic DIP |
| MAX5158EEE | -40°C to +85°C | 16 QSOP |
| MAX5158MJE | -55°C to +125°C | 16 CERDIP* |

Ordering Information continued at end of data sheet.

*Contact factory for availability.

Functional Diagram



Rail-to-Rail is a registered trademark of Nippon Motorola Ltd. Microwire is a trademark of National Semiconductor Corp. SPI and QSPI are trademarks of Motorola, Inc.



Maxim Integrated Products 1

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MAX5158/MAX5159

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

ABSOLUTE MAXIMUM RATINGS

| | |
|--|-----------------------------------|
| V_{DD} to AGND | -0.3V to +6V |
| V_{DD} to DGND | -0.3V to +6V |
| AGND to DGND | $\pm 0.3V$ |
| OSA, OSB to AGND | (AGND - 4V) to (V_{DD} + 0.3V) |
| REF ₋ , OUT ₋ to AGND | -0.3V to (V_{DD} + 0.3V) |
| Digital Inputs (SCLK, DIN, CS, CL, PDL) to DGND | (-0.3V to +6V) |
| Digital Outputs (DOUT, UPO) to DGND | -0.3V to (V_{DD} + 0.3V) |
| Maximum Current into Any Pin | $\pm 20mA$ |

| | |
|--|-----------------|
| Continuous Power Dissipation ($T_A = +70^\circ C$) | |
| Plastic DIP (derate 10.5mW/°C above +70°C) | 842mW |
| QSOP (derate 8.30mW/°C above +70°C) | 667mW |
| CERDIP (derate 10.00mW/°C above +70°C) | 800mW |
| Operating Temperature Ranges | |
| MAX515 ₋ C_E | 0°C to +70°C |
| MAX515 ₋ E_E | -40°C to +85°C |
| MAX515 ₋ MJE | -55°C to +125°C |
| Storage Temperature Range | -65°C to +160°C |
| Lead Temperature (soldering, 10sec) | +300°C |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS—MAX5158

($V_{DD} = +5V \pm 10\%$, $V_{REFA} = V_{REFB} = 2.048V$, $R_L = 10k\Omega$, $C_L = 100pF$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$ (OS₋ tied to AGND for a gain of +2V/V).)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---------------------------------------|------------------------------|---|-------|---------|----------------|--------|
| STATIC PERFORMANCE | | | | | | |
| Resolution | | | 10 | | | Bits |
| Integral Nonlinearity | INL | (Note 1) | | ± 1 | | LSB |
| Differential Nonlinearity | DNL | Guaranteed monotonic | | ± 1 | | LSB |
| Offset Error | V _{OS} ₋ | Code = 2 | | ± 6 | | mV |
| Offset Tempco | TCV _{OS} | Normalized to 2.048V | 4 | | | ppm/°C |
| Gain Error | | | -0.1 | 1 | | LSB |
| Gain-Error Tempco | | Normalized to 2.048V | 4 | | | ppm/°C |
| V_{DD} Power-Supply Rejection Ratio | PSRR | $2.7V \leq V_{DD} \leq 5.5V$ | 20 | 260 | | μV/V |
| REFERENCE INPUT | | | | | | |
| Reference Input Range | REF | | 0 | | $V_{DD} - 1.4$ | V |
| Reference Input Resistance | R _{REF} | Minimum with code 1558 hex | 18 | 25 | | kΩ |
| MULTIPLYING-MODE PERFORMANCE | | | | | | |
| Reference 3dB Bandwidth | | Input code = 1FF8 hex, $V_{REF-} = 0.67V_{pp}$ at 0.75V _{DC} | 300 | | | kHz |
| Reference Feedthrough | | Input code = 0000 hex, $V_{REF-} = (V_{DD} - 1.4 V_{pp})$ at 1kHz | -82 | | | dB |
| Signal-to-Noise plus Distortion Ratio | SINAD | Input code = 1FF8 hex, $V_{REF-} = 1V_{pp}$ at 1.25V _{DC} , f = 25kHz | 75 | | | dB |
| DIGITAL INPUTS | | | | | | |
| Input High Voltage | V _{IH} | CL, PDL, CS, DIN, SCLK | 3 | | | V |
| Input Low Voltage | V _{IL} | CL, PDL, CS, DIN, SCLK | | | 0.8 | V |
| Input Hysteresis | V _{HYS} | | 200 | | | mV |
| Input Leakage Current | I _{IN} | $V_{IN} = 0V$ to V_{DD} | 0.001 | ± 1 | | μA |
| Input Capacitance | C _{IN} | | 8 | | | pF |

Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

ELECTRICAL CHARACTERISTICS—MAX5158 (continued)

($V_{DD} = +5V \pm 10\%$, $V_{REFA} = V_{REFB} = 2.048V$, $R_L = 10k\Omega$, $C_L = 100pF$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$ (OS₊ tied to AGND for a gain of +2V/V).)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---|----------------|---|----------------|---------|------------|-------|
| DIGITAL OUTPUTS (DOUT, UPO) | | | | | | |
| Output High Voltage | V_{OH} | $I_{SOURCE} = 2mA$ | $V_{DD} - 0.5$ | | V | |
| Output Low Voltage | V_{OL} | $I_{SINK} = 2mA$ | 0.13 | | 0.4 | V |
| DYNAMIC PERFORMANCE | | | | | | |
| Voltage Output Slew Rate | SR | | 0.75 | | V/ μ s | |
| Output Settling Time | | To 1/2LSB of full-scale, $V_{STEP} = 4V$ | 8 | | μ s | |
| Output Voltage Swing | | Rail-to-rail (Note 2) | 0 to V_{DD} | | V | |
| OSA or OSB Input Resistance | R_{OS} | | 24 | 34 | $k\Omega$ | |
| Time Required to Exit Shutdown | | | 25 | | μ s | |
| Digital Feedthrough | | $\bar{CS} = V_{DD}$, $f_{DIN} = 100kHz$, $V_{SCLK} = 5Vp-p$ | 5 | | nV-s | |
| Digital Crosstalk | | | 5 | | nV-s | |
| POWER SUPPLIES | | | | | | |
| Positive Supply Voltage | V_{DD} | | 4.5 | 5.5 | V | |
| Power-Supply Current | I_{DD} | (Note 3) | 0.5 | 0.65 | mA | |
| Power-Supply Current in Shutdown | $I_{DD(SHDN)}$ | (Note 3) | 2 | 10 | μ A | |
| Reference Current in Shutdown | | | 0 | ± 1 | μ A | |
| TIMING CHARACTERISTICS | | | | | | |
| SCLK Clock Period | t_{CP} | (Note 4) | 100 | | ns | |
| SCLK Pulse Width High | t_{CH} | | 40 | | ns | |
| SCLK Pulse Width Low | t_{CL} | | 40 | | ns | |
| \bar{CS} Fall to SCLK Rise Setup Time | t_{CSS} | | 40 | | ns | |
| SCLK Rise to \bar{CS} Rise Hold Time | t_{CSH} | | 0 | | ns | |
| SDI Setup Time | t_{DS} | | 40 | | ns | |
| SDI Hold Time | t_{DH} | | 0 | | ns | |
| SCLK Rise to DOUT Valid Propagation Delay | t_{D01} | $C_{LOAD} = 200pF$ | 80 | | ns | |
| SCLK Fall to DOUT Valid Propagation Delay | t_{D02} | $C_{LOAD} = 200pF$ | 80 | | ns | |
| SCLK Rise to \bar{CS} Fall Delay | t_{CS0} | | 10 | | ns | |
| \bar{CS} Rise to SCLK Rise Hold | t_{CS1} | | 40 | | ns | |
| \bar{CS} Pulse Width High | t_{CSW} | | 100 | | ns | |

Note 1: Accuracy is specified from code 2 to code 1023.

Note 2: Accuracy is better than 1LSB for V_{OUT} greater than 6mV and less than $V_{DD} - 50mV$. Guaranteed by PSRR test at the end points.

Note 3: Digital inputs are set to either V_{DD} or DGND, code = 0000 hex, $R_L = \infty$.

Note 4: SCLK minimum clock period includes rise and fall times.

MAX5158/MAX5159

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

ELECTRICAL CHARACTERISTICS—MAX5159

($V_{DD} = +2.7V$ to $+3.6V$, $V_{REFA} = V_{REFB} = 1.25V$, $R_L = 10k\Omega$, $C_L = 100pF$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$ (OS_- pins tied to AGND for a gain of $+2V/V$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|------------|---|----------------|----------------|-----|-----------------|
| STATIC PERFORMANCE | | | | | | |
| Resolution | | | 10 | | | Bits |
| Integral Nonlinearity | INL | (Note 5) | | ± 1 | | LSB |
| Differential Nonlinearity | DNL | Guaranteed monotonic | | ± 1 | | LSB |
| Offset Error | V_{OS} | Code = 3 | | ± 6 | | mV |
| Offset Tempco | TCV_{OS} | Normalized to 1.25V | 6.5 | | | ppm/ $^\circ C$ |
| Gain Error | | | -0.1 | ± 1 | | LSB |
| Gain-Error Tempco | | Normalized to 1.25V | 6.5 | | | ppm/ $^\circ C$ |
| V_{DD} Power-Supply Rejection Ratio | PSRR | $2.7V \leq V_{DD} \leq 3.6V$ | 40 | 320 | | $\mu V/V$ |
| REFERENCE INPUT (VREF) | | | | | | |
| Reference Input Range | REF | | 0 | $V_{DD} - 1.4$ | | V |
| Reference Input Resistance | R_{REF} | Minimum with code 1558 hex | 18 | 25 | | $k\Omega$ |
| MULTIPLYING-MODE PERFORMANCE | | | | | | |
| Reference 3dB Bandwidth | | Input code = 1FF8 hex, $V_{REF_} = 0.67V_{p-p}$ at $0.75V_{DC}$ | 300 | | | kHz |
| Reference Feedthrough | | Input code = 0000 hex, $V_{REF_} = (V_{DD} - 1.4)V_{p-p}$ at 1kHz | -82 | | | dB |
| Signal-to-Noise plus Distortion Ratio | SINAD | Input code = 1FF8 hex, $V_{REF_} = 1V_{p-p}$ at $1V_{DC}$, $f = 15kHz$ | 73 | | | dB |
| DIGITAL INPUTS | | | | | | |
| Input High Voltage | V_{IH} | \overline{CL} , \overline{PDL} , \overline{CS} , DIN, SCLK | 2.2 | | | V |
| Input Low Voltage | V_{IL} | \overline{CL} , \overline{PDL} , \overline{CS} , DIN, SCLK | | 0.8 | | V |
| Input Hysteresis | V_{HYS} | | 200 | | | mV |
| Input Leakage Current | I_{IN} | $V_{IN} = 0V$ to V_{DD} | 0 | ± 1 | | μA |
| Input Capacitance | C_{IN} | | 8 | | | pF |
| DIGITAL OUTPUTS | | | | | | |
| Output High Voltage | V_{OH} | $I_{SOURCE} = 2mA$ | $V_{DD} - 0.5$ | | | V |
| Output Low Voltage | V_{OL} | $I_{SINK} = 2mA$ | 0.13 | 0.4 | | V |
| DYNAMIC PERFORMANCE (DOUT, UPO) | | | | | | |
| Voltage Output Slew Rate | SR | | 0.75 | | | $V/\mu s$ |
| Output Settling Time | | To 1/2LSB of full-scale, $V_{STEP} = 2.5V$ | 8 | | | μs |
| Output Voltage Swing | | Rail-to-rail (Note 6) | 0 to V_{DD} | | | V |
| OSA or OSB Input Resistance | $R_{OS_}$ | | 24 | 34 | | $k\Omega$ |
| Time Required for Valid Operation after Shutdown | | | 25 | | | μs |
| Digital Feedthrough | | $\overline{CS} = V_{DD}$, $f_{DIN} = 100kHz$, $V_{SCLK} = 3V_{p-p}$ | 5 | | | $nV \cdot s$ |
| Digital Crosstalk | | | 5 | | | $nV \cdot s$ |

Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

ELECTRICAL CHARACTERISTICS—MAX5159 (continued)

($V_{DD} = +2.7V$ to $+3.6V$, $V_{REFA} = V_{REFB} = 1.25V$, $R_L = 10k\Omega$, $C_L = 100pF$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$ ($OS_{_}$ pins tied to AGND for a gain of $+2V/V$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|----------------|--------------------|-----|-----|---------|---------|
| POWER SUPPLIES | | | | | | |
| Positive Supply Voltage | V_{DD} | | 2.7 | 3.6 | | V |
| Power-Supply Current | I_{DD} | (Note 7) | | 0.5 | 0.6 | mA |
| Power-Supply Current in Shutdown | $I_{DD(SHDN)}$ | (Note 7) | | 1 | 8 | μA |
| Reference Current in Shutdown | | | | | ± 1 | μA |
| TIMING CHARACTERISTICS | | | | | | |
| SCLK Clock Period | t_{CP} | (Note 4) | 100 | | | ns |
| SCLK Pulse Width High | t_{CH} | | 40 | | | ns |
| SCLK Pulse Width Low | t_{CL} | | 40 | | | ns |
| \overline{CS} Fall to SCLK Rise Setup Time | t_{CSS} | | 40 | | | ns |
| SCLK Rise to \overline{CS} Rise Hold Time | t_{CSH} | | 0 | | | ns |
| SDI Setup Time | t_{DS} | | 50 | | | ns |
| SDI Hold Time | t_{DH} | | 0 | | | ns |
| SCLK Rise to DOUT Valid Propagation Delay | t_{DO1} | $C_{LOAD} = 200pF$ | | 120 | | ns |
| SCLK Fall to DOUT Valid Propagation Delay | t_{DO2} | $C_{LOAD} = 200pF$ | | 120 | | ns |
| SCLK Rise to \overline{CS} Fall Delay | t_{CS0} | | 10 | | | ns |
| \overline{CS} Rise to SCLK Rise Hold | t_{CS1} | | 40 | | | ns |
| \overline{CS} Pulse Width High | t_{CSW} | | 100 | | | ns |

Note 5: Accuracy is specified from code 3 to code 1023.

Note 6: Accuracy is better than 1LSB for V_{OUT} greater than 6mV and less than $V_{DD} - 80mV$. Guaranteed by PSRR test at the end points.

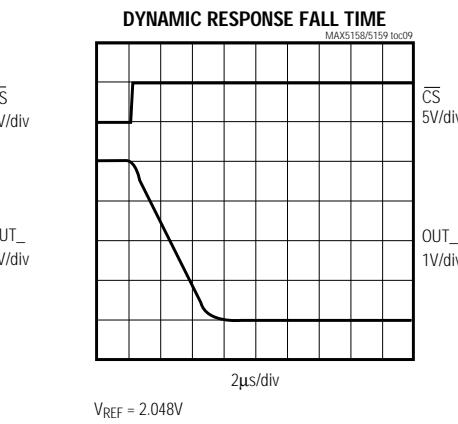
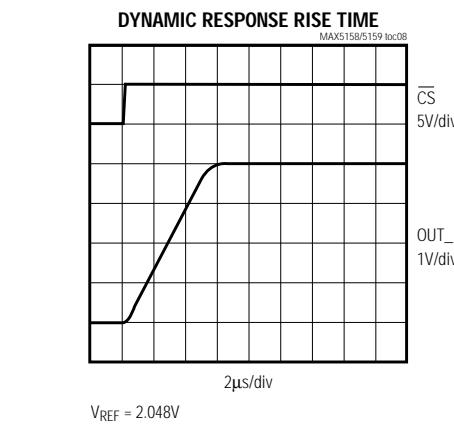
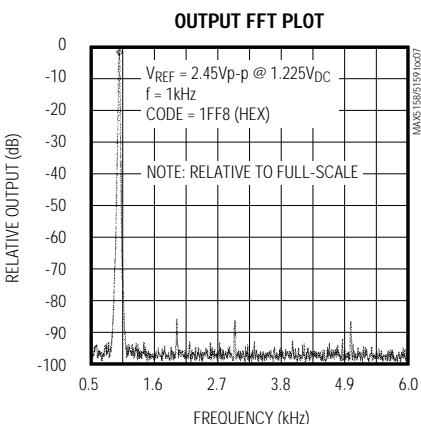
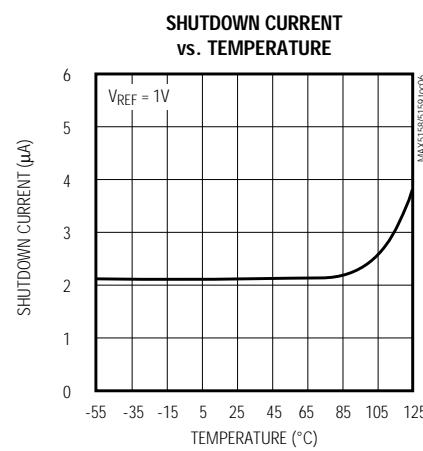
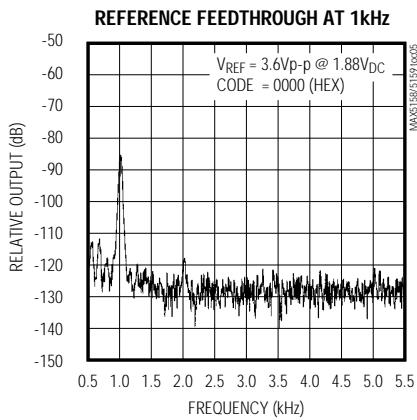
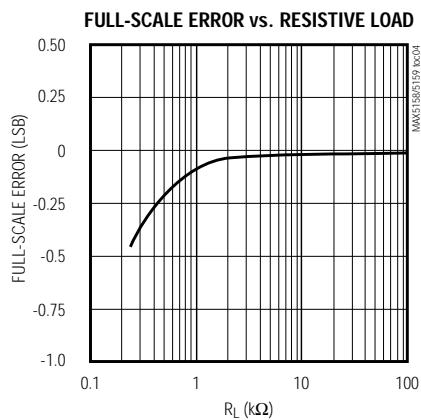
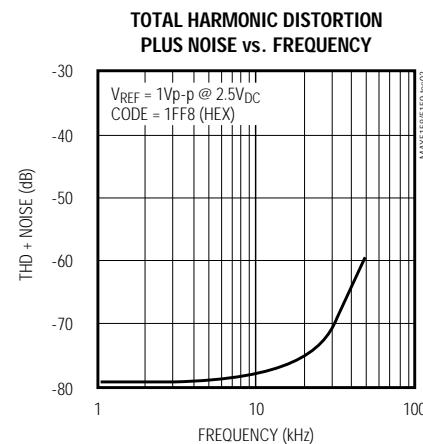
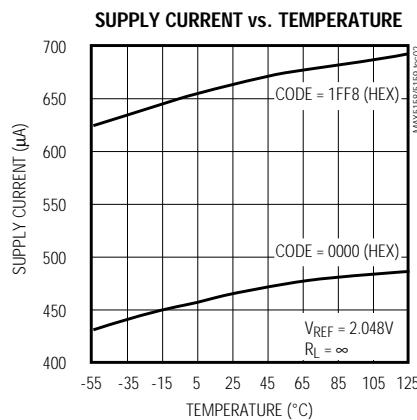
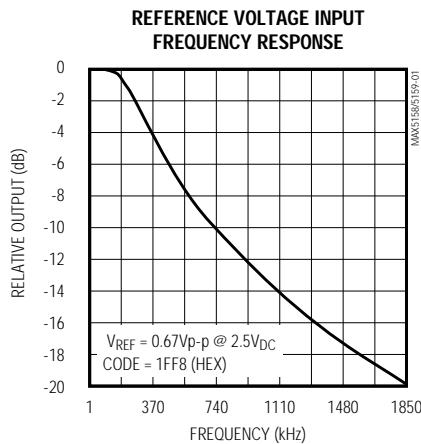
Note 7: Digital inputs are set to either V_{DD} or DGND, code = 0000 hex, $R_L = \infty$.

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

Typical Operating Characteristics

($V_{DD} = +5V$, $R_L = 10k\Omega$, $C_L = 100pF$, OS_{-} pins tied to AGND, $T_A = +25^\circ C$, unless otherwise noted.)

MAX5158

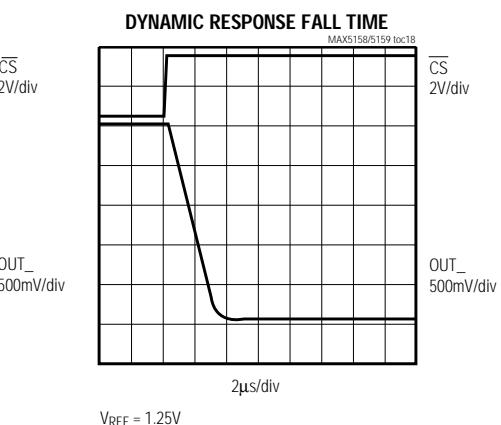
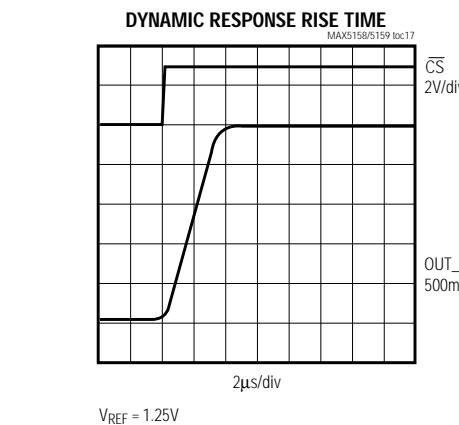
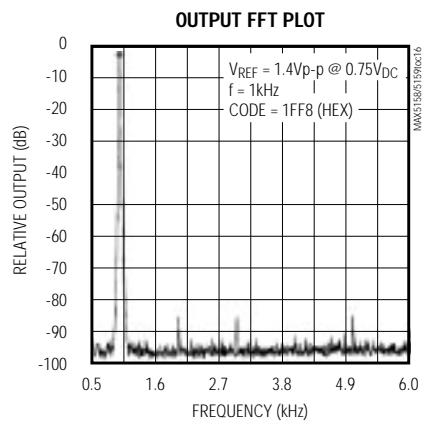
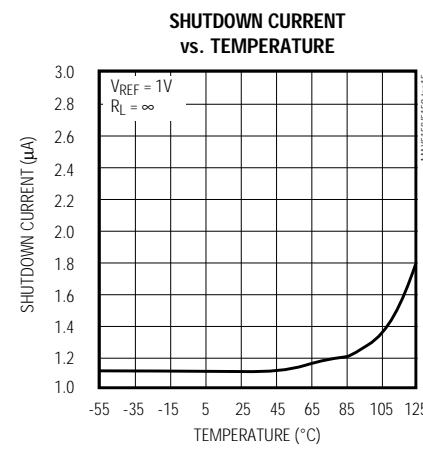
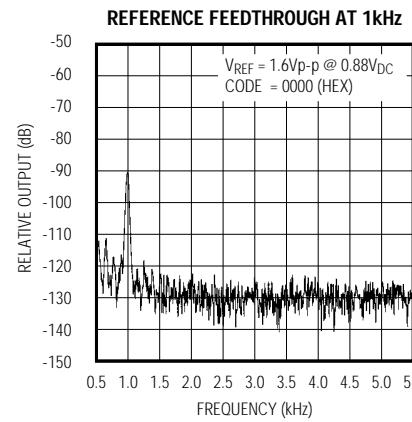
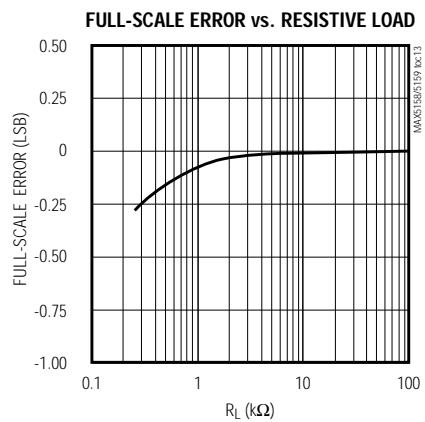
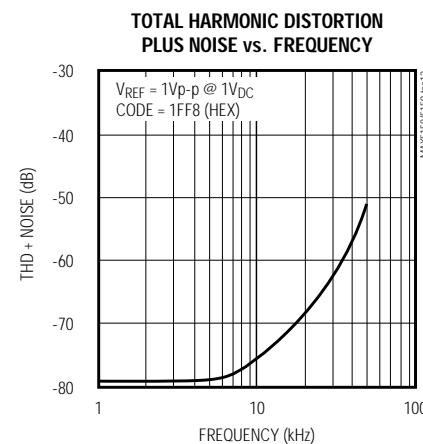
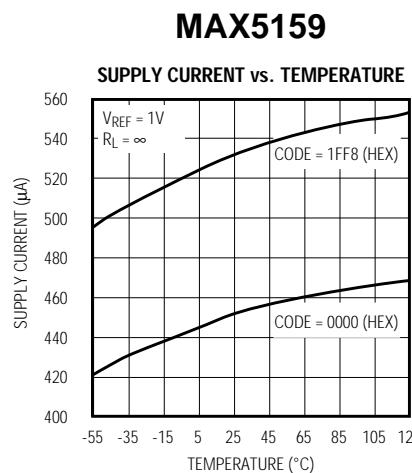
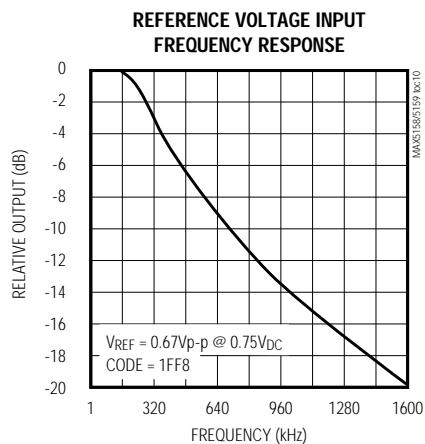


Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

Typical Operating Characteristics (continued)

($V_{DD} = +3V$, $R_L = 10k\Omega$, $C_L = 100pF$, OS_ pins tied to AGND, $T_A = +25^\circ C$, unless otherwise noted.)

MAX5158/MAX5159

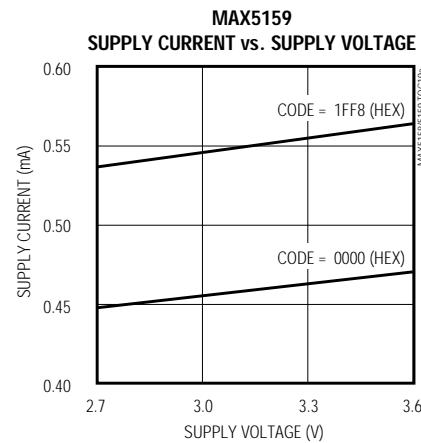
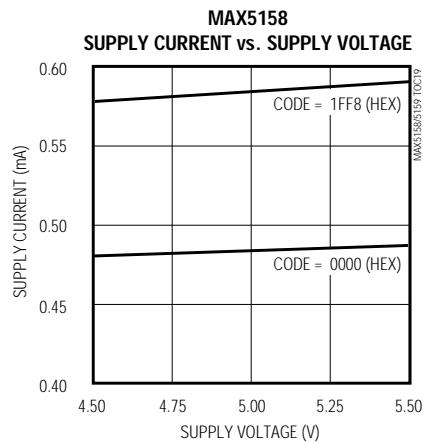


Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

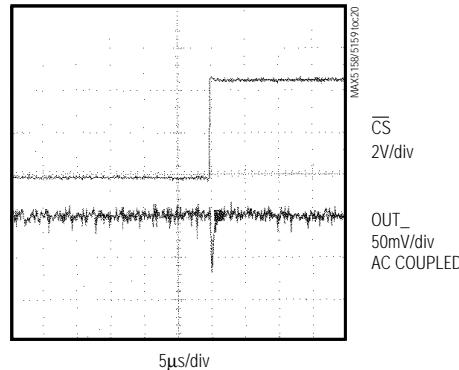
Typical Operating Characteristics (continued)

($V_{DD} = +5V$ (MAX5158), $V_{DD} = +3V$ (MAX5159), $R_L = 10k\Omega$, $C_L = 100pF$, OS_- pins tied to AGND, unless otherwise noted.)

MAX5158/MAX5159

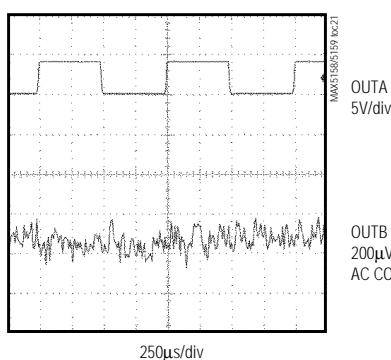


MAX5158 MAJOR-CARRY TRANSITION



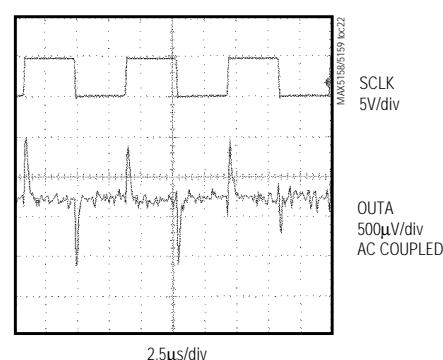
TRANSITION FROM 1000 (HEX) TO OFF8 (HEX)

MAX5158 ANALOG CROSSTALK



$V_{REF} = 2.048V$, GAIN = +2V/V, CODE = 1FF8 HEX

MAX5158 DIGITAL FEEDTHROUGH



Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

Pin Description

| PIN | NAME | FUNCTION |
|-----|------------------|---|
| 1 | AGND | Analog Ground |
| 2 | OUTA | DAC A Output Voltage |
| 3 | OSA | DAC A Offset Adjustment |
| 4 | REFA | Reference for DAC A |
| 5 | \overline{CL} | Active-Low Clear Input. Resets all registers to zero. DAC outputs go to 0V. |
| 6 | \overline{CS} | Chip-Select Input |
| 7 | DIN | Serial-Data Input |
| 8 | SCLK | Serial Clock Input |
| 9 | DGND | Digital Ground |
| 10 | DOUT | Serial-Data Output |
| 11 | UPO | User-Programmable Output |
| 12 | \overline{PDL} | Power-Down Lockout. The device cannot be powered down when \overline{PDL} is low. |
| 13 | REFB | Reference for DAC B |
| 14 | OSB | DAC B Offset Adjustment |
| 15 | OUTB | DAC B Output Voltage |
| 16 | VDD | Positive Power Supply |

Detailed Description

The MAX5158/MAX5159 dual, 10-bit, voltage-output DACs are easily configured with a 3-wire serial interface. These devices include a 16-bit data-in/data-out shift register, and each DAC has a double-buffered input composed of an input register and a DAC register (see *Functional Diagram*). In addition, trimmed internal resistors produce an internal gain of +2V/V that maximizes output voltage swing. The amplifier's offset-adjust pin allows for a DC shift in the DAC's output.

Both DACs use an inverted R-2R ladder network that produces a weighted voltage proportional to the input voltage value. Each DAC has its own reference input to facilitate independent full-scale values. Figure 1 depicts a simplified circuit diagram of one of the two DACs.

Reference Inputs

The reference inputs accept both AC and DC values with a voltage range extending from 0V to $(V_{DD} - 1.4V)$. Determine the output voltage using the following equation ($OS_- = AGND$):

MAXIM

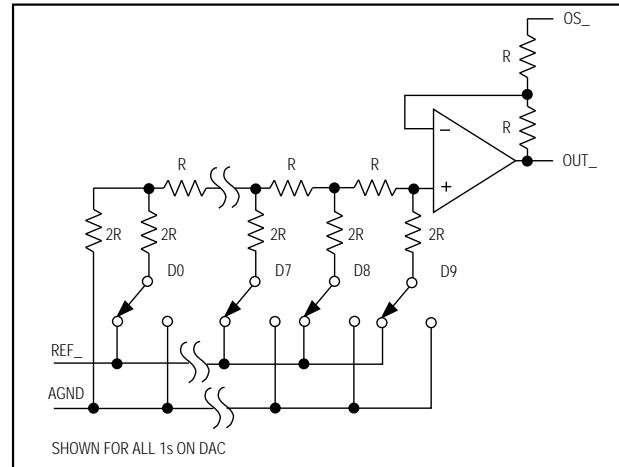


Figure 1. Simplified DAC Circuit Diagram

$$V_{OUT} = (V_{REF} \times NB / 1024) \times 2$$

where NB is the numeric value of the DAC's binary input code (0 to 1023) and V_{REF} is the reference voltage.

The reference input impedance ranges from 18k Ω (1558 hex) to several giga ohms (with an input code of 0000 hex). The reference input capacitance is code dependent and typically ranges from 15pF with an input code of all zeros to 50pF with a full-scale input code.

Output Amplifier

The output amplifiers on the MAX5158/MAX5159 have internal resistors that provide for a gain of +2V/V when OS₋ is connected to AGND. These resistors are trimmed to minimize gain error. The output amplifiers have a typical slew rate of 0.75V/ μ s and settle to 1/2LSB within 8 μ s, with a load of 10k Ω in parallel with 100pF. Loads less than 2k Ω degrade performance.

The OS₋ pin can be used to produce an adjustable offset voltage at the output. For instance, to achieve a 1V offset, apply -1V to the OS₋ pin to produce an output range from 1V to $(1V + V_{REF} \times 2)$. Note that the DAC's output range is still limited by the maximum output voltage specification.

Power-Down Mode

The MAX5158/MAX5159 feature a software-programmable shutdown mode that reduces the typical supply current to 2 μ A. The two DACs can be shutdown independently, or simultaneously using the appropriate programming command. Enter shutdown mode by writing the appropriate input-control word (Table 1). In shutdown mode, the reference inputs and amplifier outputs become high impedance, and the serial interface

MAX5158/MAX5159

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

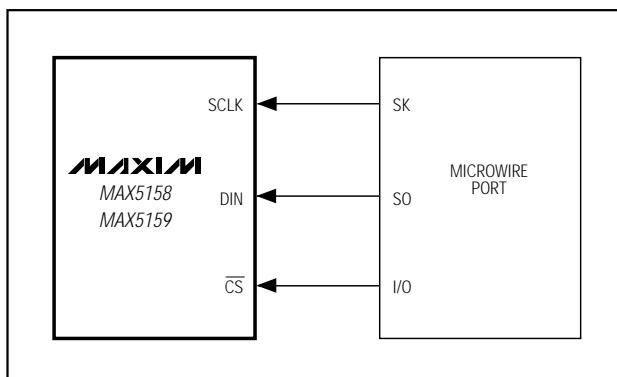


Figure 2. Connections for Microwire

Table 1. Serial-Interface Programming Command

| 16-BIT SERIAL WORD | | | | FUNCTION |
|--------------------|----|----|------------------------------------|---|
| A0 | C1 | C0 | D9.....D0 (MSB).....D0 (LSB) | |
| 0 | 0 | 1 | 10-bit DAC data | Load input register A; DAC registers are unchanged. |
| 1 | 0 | 1 | 10-bit DAC data | Load input register B; DAC registers are unchanged. |
| 0 | 1 | 0 | 10-bit DAC data | Load input register A; all DAC registers are updated. |
| 1 | 1 | 0 | 10-bit DAC data | Load input register B; all DAC registers are updated. |
| 0 | 1 | 1 | 10-bit DAC data | Load all DAC registers from the shift register (start up both DACs with new data.). |
| 1 | 0 | 0 | xxxxxxxxxx | Update both DAC registers from their respective input registers (start up both DACs with data previously stored in the input registers). |
| 1 | 1 | 1 | xxxxxxxxxx | Shut down both DACs (provided $\overline{PDL} = 1$). |
| 0 | 0 | 0 | 0 0 1 x xxxxxx | Update DAC register A from input register A (start up DAC A with data previously stored in input register A). |
| 0 | 0 | 0 | 1 0 1 x xxxxxx | Update DAC register B from input register B (start up DAC B with data previously stored in input register B). |
| 0 | 0 | 0 | 1 1 0 x xxxxxx | Shut down DAC A (provided $\overline{PDL} = 1$). |
| 0 | 0 | 0 | 1 1 1 x xxxxxx | Shut down DAC B (provided $\overline{PDL} = 1$). |
| 0 | 0 | 0 | 0 1 0 x xxxxxx | UPO goes low (default). |
| 0 | 0 | 0 | 0 1 1 x xxxxxx | UPO goes high. |
| 0 | 0 | 0 | 1 0 0 1 xxxxxx | Mode 1, DOUT clocked out on SCLK's rising edge. |
| 0 | 0 | 0 | 1 0 0 0 xxxxxx | Mode 0, DOUT clocked out on SCLK's falling edge (default). |
| 0 | 0 | 0 | 0 0 0 x xxxxxx | No operation (NOP). |

x = Don't care

Note: When A0, C1, and C0 = 0, then D9, D8, D7, and D6 become control bits. S2–S0 are sub bits, always zero.

Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

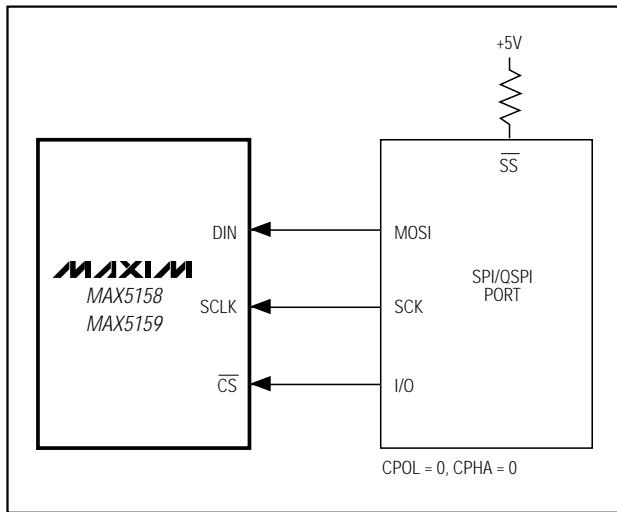


Figure 3. Connections for SPI/QSPI

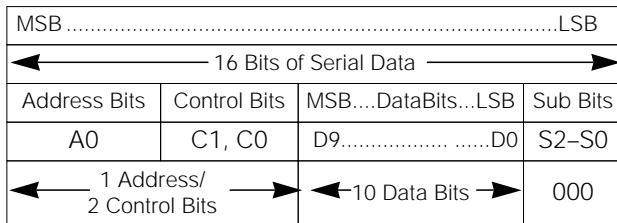


Figure 4. Serial-Data Format

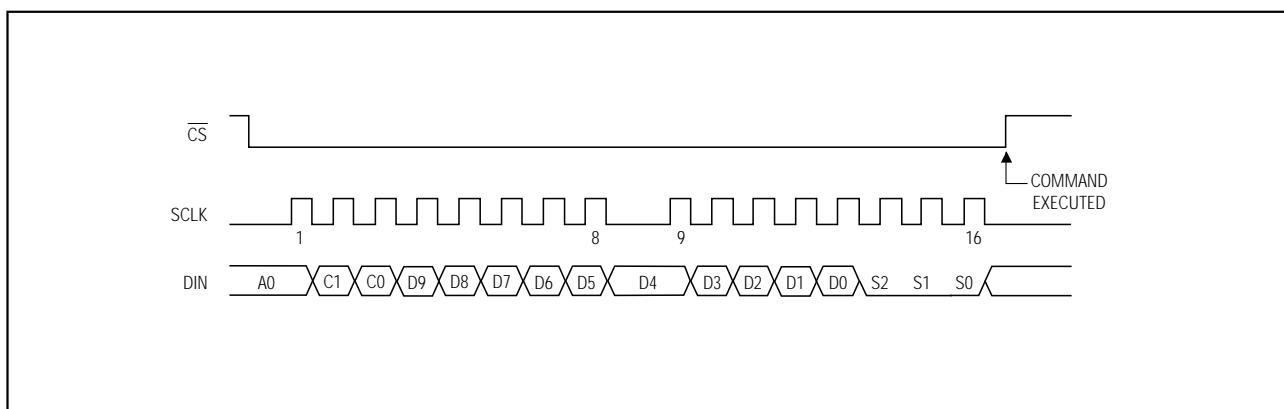


Figure 5. Serial-Interface Timing Diagram

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

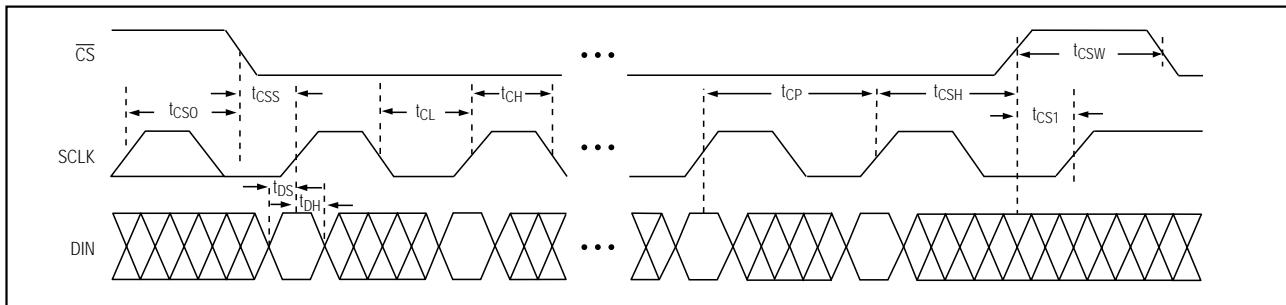


Figure 6. Detailed Serial-Interface Timing Diagram

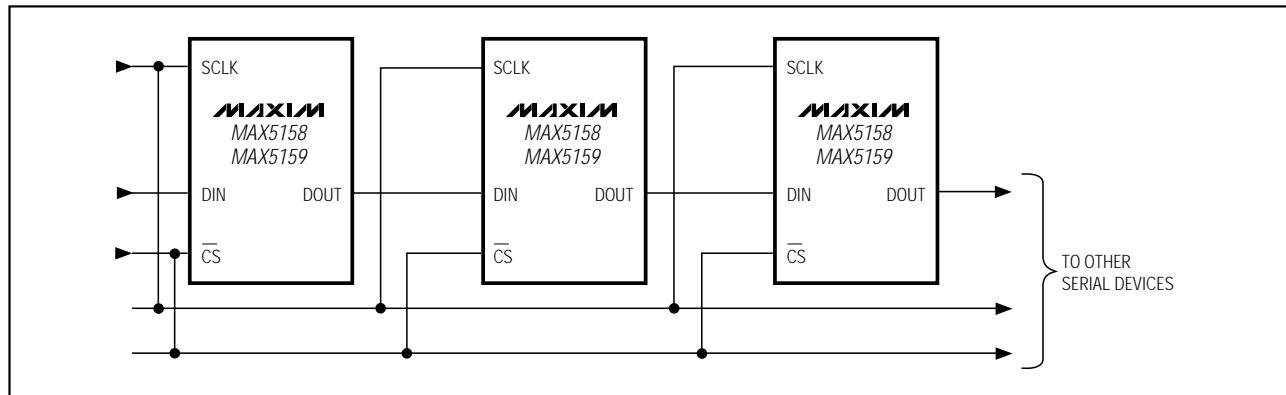


Figure 7. Daisy Chaining MAX5158/MAX5159s

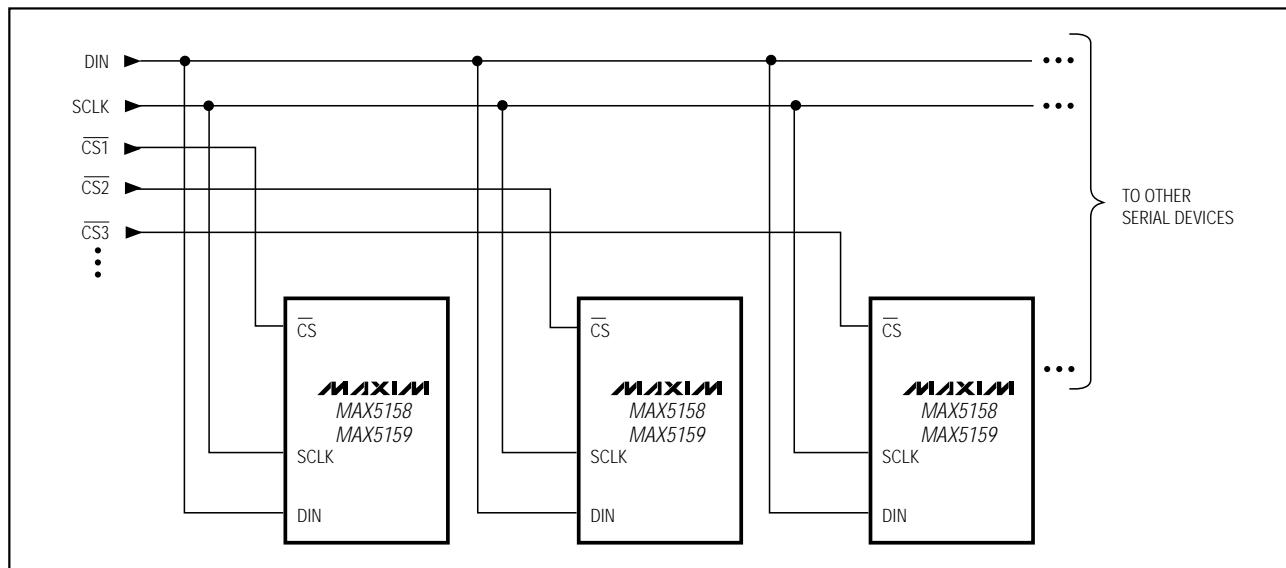


Figure 8. Multiple MAX5158/MAX5159s Sharing a Common DIN Line

Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

Table 2. Unipolar Code Table (Gain = +2)

| DAC CONTENTS MSB | LSB | ANALOG OUTPUT |
|---------------------|-----|---|
| 11 1111 1111 (000) | | $+V_{REF} \left(\frac{1023}{1024} \right) \times 2$ |
| 10 0000 0001 (000) | | $+V_{REF} \left(\frac{513}{1024} \right) \times 2$ |
| 10 0000 0000 (000) | | $+V_{REF} \left(\frac{512}{1024} \right) \times 2 = V_{REF}$ |
| 01 1111 1111 (000) | | $+V_{REF} \left(\frac{511}{1024} \right) \times 2$ |
| 00 0000 0001 (000) | | $+V_{REF} \left(\frac{1}{1024} \right)$ |
| 00 0000 0000 (000) | | 0V |

Note: () are for the sub bits.

Serial-Data Output

The serial-data output, DOUT, is the internal shift register's output. DOUT allows for daisy chaining of devices and data readback. The MAX5158/MAX5159 can be programmed to shift data out of DOUT on SCLK's falling edge (Mode 0) or on the rising edge (Mode 1). Mode 0 provides a lag of 16 clock cycles, which maintains compatibility with SPI/QSPI and Microwire interfaces. In Mode 1, the output data lags 15.5 clock cycles. On power-up, the device defaults to Mode 0.

User-Programmable Logic Output (UPO)

UPO allows an external device to be controlled through the serial interface (Table 1), thereby reducing the number of microcontroller I/O pins required. On power-up, UPO is low.

Power-Down Lockout Input (PDL)

The power-down lockout pin (PDL) disables software shutdown when low. When in shutdown, transitioning PDL from high to low wakes up the part with the output set to the state prior to shutdown. PDL can also be used to asynchronously wake up the device.

Daisy Chaining Devices

Any number of MAX5158/MAX5159s can be daisy chained by connecting the DOUT pin of one device to the DIN pin of the following device in the chain (Figure 7). Since the MAX5158/MAX5159's DOUT pin has an internal active pull-up, the DOUT sink/source capability determines the time required to discharge/charge a capacitive

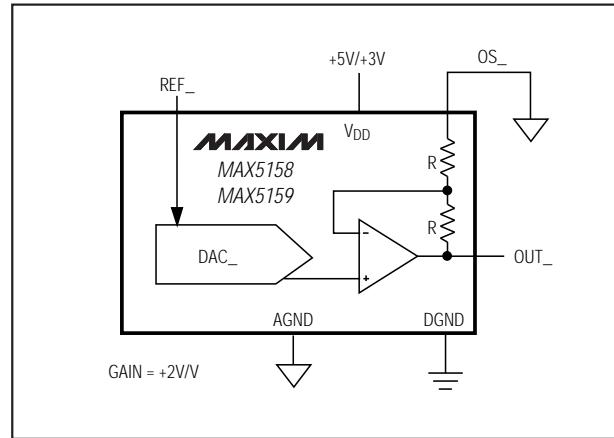


Figure 9. Unipolar Output Circuit (Rail-to-Rail)

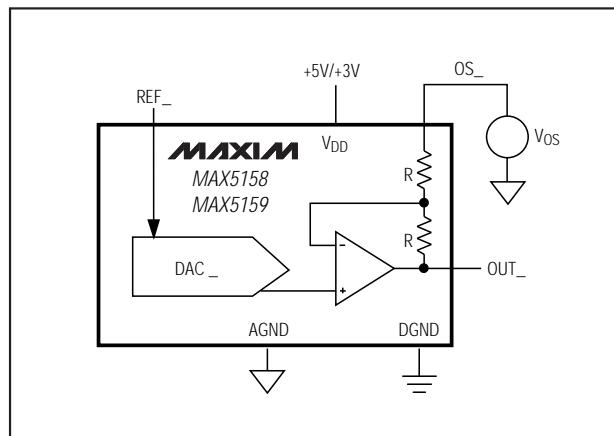


Figure 10. Setting OS_ for Output Offset

load. Refer to the digital output V_{OH} and V_{OL} specifications in the *Electrical Characteristics*.

Figure 8 shows an alternate method of connecting several MAX5158/MAX5159s. In this configuration, the data bus is common to all devices; data is not shifted through a daisy chain. More I/O lines are required in this configuration because a dedicated chip-select input (\overline{CS}) is required for each IC.

Applications Information

Unipolar Output

Figure 9 shows the MAX5158/MAX5159 configured for unipolar, rail-to-rail operation with a gain of +2V/V. The MAX5158 can produce a 0V to 4.096V output with a 2.048V reference (Figure 9), while the MAX5159 can

Low-Power, Dual, 10-Bit Voltage-Output DACs with Serial Interface

Table 3. Bipolar Code Table

| DAC CONTENTS | | ANALOG OUTPUT |
|--------------|-------|--|
| MSB | LSB | |
| 11 1111 1111 | (000) | $+V_{REF} \left(\frac{511}{512} \right)$ |
| 10 0000 0001 | (000) | $+V_{REF} \left(\frac{1}{512} \right)$ |
| 10 0000 0000 | (000) | 0V |
| 01 1111 1111 | (000) | $-V_{REF} \left(\frac{1}{512} \right)$ |
| 00 0000 0001 | (000) | $-V_{REF} \left(\frac{511}{512} \right)$ |
| 00 0000 0000 | (000) | $-V_{REF} \left(\frac{512}{512} \right) = -V_{REF}$ |

Note: () are for the sub bits.

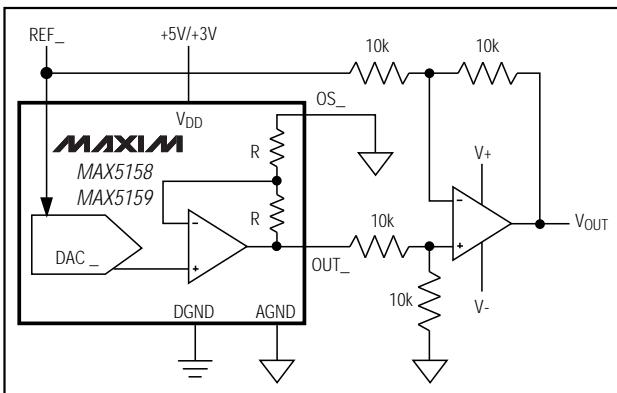


Figure 11. Bipolar Output Circuit

produce a range of 0V to 2.5V with a 1.25V reference. Table 2 lists the unipolar output codes. An offset to the output can be achieved by connecting a voltage to OS_- , as shown in Figure 10. By applying $V_{OS_-} = -1V$, the output values will range between 1V and $(1V + V_{REF} \times 2)$.

Bipolar Output

The MAX5158/MAX5159 can be configured for a bipolar output, as shown in Figure 11. The output voltage is given by the equation ($OS_- = AGND$):

$$V_{OUT} = V_{REF} \left[\left(\frac{2 \times NB}{1024} \right) - 1 \right]$$

where NB represents the numeric value of the DAC's binary input code. Table 3 shows digital codes and the corresponding output voltage for Figure 11's circuit.

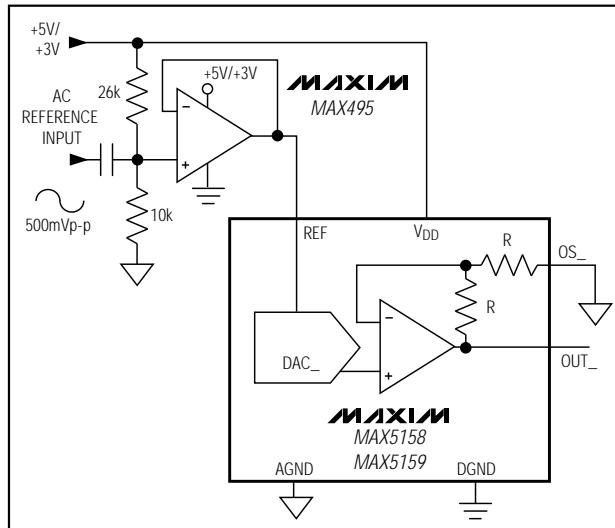


Figure 12. AC Reference Input Circuit

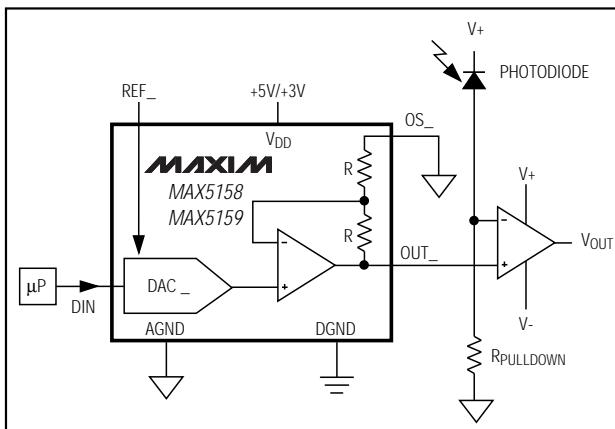


Figure 13. Digital Calibration

Using an AC Reference

In applications where the reference has an AC signal component, the MAX5158/MAX5159 have multiplying capabilities within the reference input voltage range specifications. Figure 12 shows a technique for applying a sinusoidal input to REF_- , where the AC signal is offset before being applied to the reference input.

Harmonic Distortion and Noise

The total harmonic distortion plus noise (THD+N) is typically less than -78dB at full scale with a 1Vp-p input swing at 5kHz. The typical -3dB frequency is 300kHz for both devices, as shown in the *Typical Operating Characteristics*.

Low-Power, Dual, 10-Bit, Voltage-Output DACs with Serial Interface

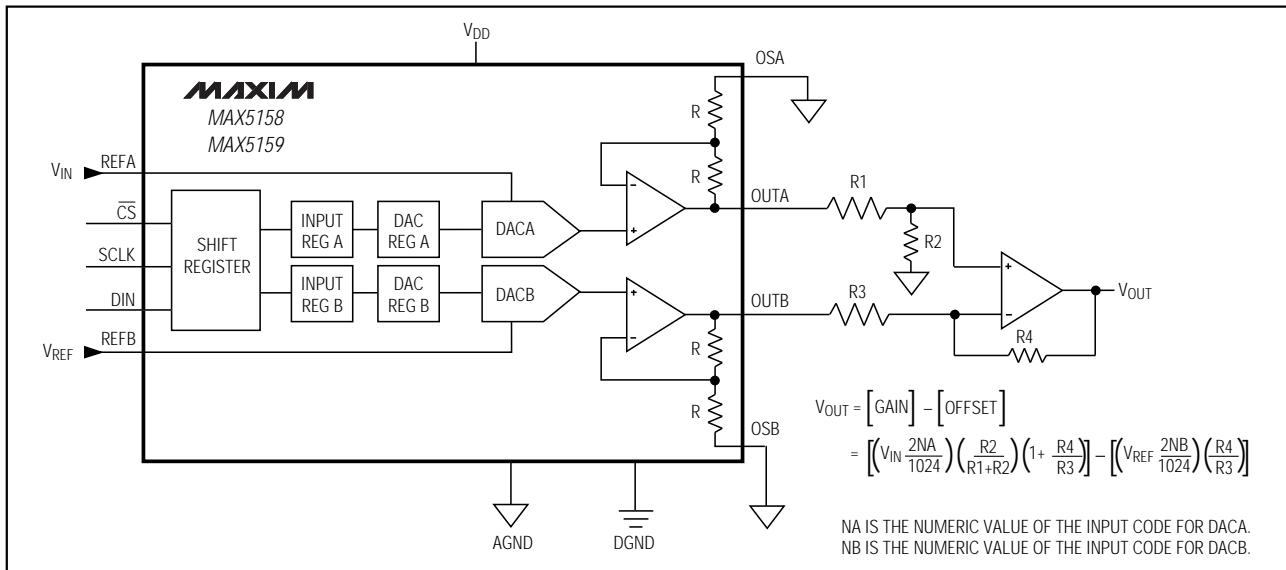


Figure 14. Digital Control of Gain and Offset

Digital Calibration and Threshold Selection

Figure 13 shows the MAX5158/MAX5159 in a digital calibration application. With a bright light value applied to the photodiode (on), the DAC is digitally ramped until it trips the comparator. The microprocessor (μ P) stores this "high" calibration value. Repeat the process with a dim light (off) to obtain the dark current calibration. The μ P then programs the DAC to set an output voltage at the midpoint of the two calibrated values. Applications include tachometers, motion sensing, automatic readers, and liquid clarity analysis.

Digital Control of Gain and Offset

The two DACs can be used to control the offset and gain for curve-fitting nonlinear functions, such as transducer linearization or analog compression/expansion applications. The input signal is used as the reference for the gain-adjust DAC, whose output is summed with the output from the offset-adjust DAC. The relative weight of each DAC output is adjusted by R1, R2, R3, and R4 (Figure 14).

Power-Supply Considerations

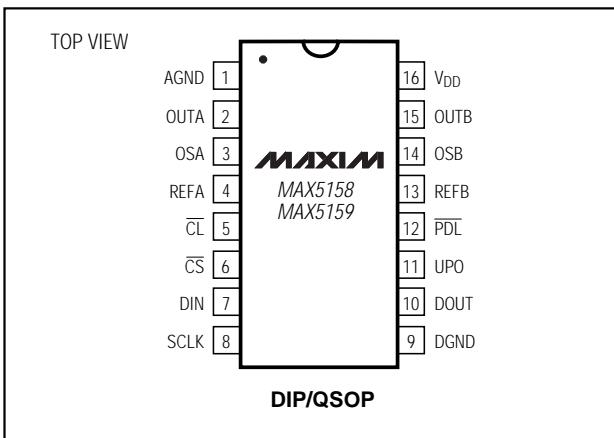
On power-up, the input and DAC registers clear (set to zero code). For rated performance, VREF_ should be at least 1.4V below VDD. Bypass the power supply with a 4.7 μ F capacitor in parallel with a 0.1 μ F capacitor to AGND. Minimize lead lengths to reduce lead inductance.

Grounding and Layout Considerations

Digital and AC transient signals on AGND can create noise at the output. Connect AGND to the highest quality ground available. Use proper grounding techniques, such as a multilayer board with a low-inductance ground plane. Carefully lay out the traces between channels to reduce AC cross-coupling and crosstalk. Wire-wrapped boards and sockets are not recommended. If noise becomes an issue, shielding may be required.

Low-Power, Dual, 13-Bit Voltage-Output DACs with Serial Interface

Pin Configuration



Ordering Information (continued)

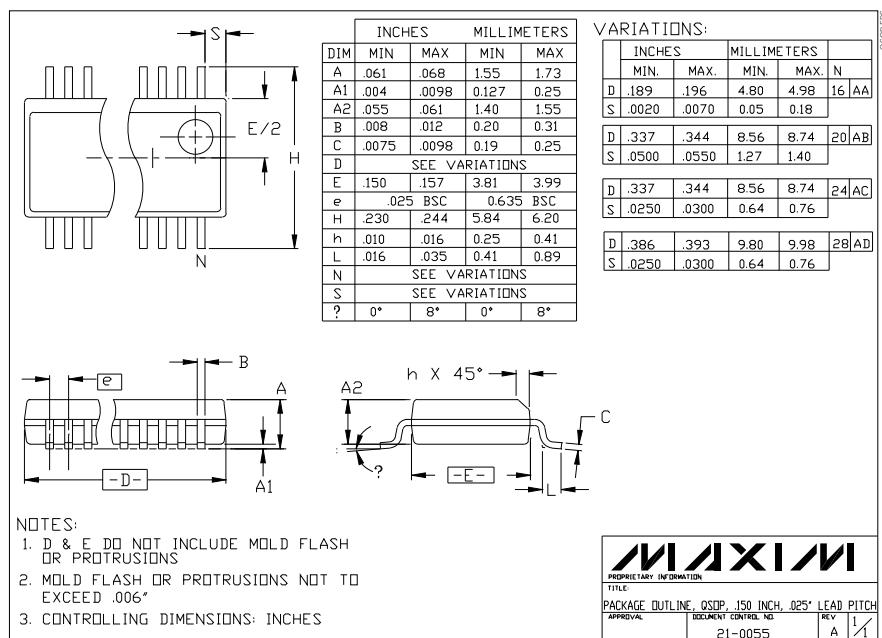
| PART | TEMP. RANGE | PIN-PACKAGE |
|-------------------|-----------------|----------------|
| MAX5159CPE | 0°C to +70°C | 16 Plastic DIP |
| MAX5159CEE | 0°C to +70°C | 16 QSOP |
| MAX5159EPE | -40°C to +85°C | 16 Plastic DIP |
| MAX5159EEE | -40°C to +85°C | 16 QSOP |
| MAX5159MJE | -55°C to +125°C | 16 CERDIP* |

*Contact factory for availability.

Chip Information

TRANSISTOR COUNT: 3053
SUBSTRATE CONNECTED TO AGND

Package Information



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